

T-39-13

MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA

意商 2N6826 供应商

Designer's Data Sheet
Power Field Effect Transistor
N-Channel Enhancement-Mode
Silicon Gate TMOS

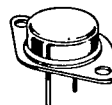
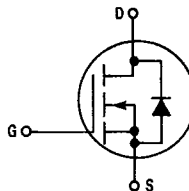
These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data — I_{DSS} , $V_{DS(on)}$, $V_{GS(th)}$ and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



2N6826

TMOS POWER FETs
6 AMPERES
 $r_{DS(on)} = 1.6 \text{ OHM}$
600 VOLTS



CASE 1-06
TO-204AA

MAXIMUM RATINGS

Rating	Symbol	2N6826	Unit
Drain-Source Voltage	V_{DSS}	600	Vdc
Drain-Gate Voltage ($R_{GS} = 1 \text{ M}\Omega$)	V_{DGR}	600	Vdc
Gate-Source Voltage	V_{GS}	± 20	Vdc
Drain Current			Adc
Continuous @ $T_C = 25^\circ\text{C}$	I_D	6	
Pulsed @ $T_C = 100^\circ\text{C}$	I_{DM}	30	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	150	Watts W/°C
Operating Junction Temperature Range	T_J	-65 to 150	°C
Storage Temperature Range	T_{stg}	-65 to 175	°C

THERMAL CHARACTERISTICS

Thermal Resistance	Symbol	Value	Unit
Junction to Case	$R_{\theta JC}$	0.83	°C/W
Junction to Ambient	$R_{\theta JA}$	30	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	°C

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

Electrical Characteristics (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Drain-Source Breakdown Voltage (V _{GS} = 0, I _D = 0.25 mA)	V(BR)DSS	600	—	Vdc	
Zero Gate Voltage Drain Current (V _{DS} = Rated V _{DSS} , V _{GS} = 0) (V _{DS} = 0.8 Rated V _{DSS} , V _{GS} = 0, T _J = 125°C)	I _{DSS}	—	0.25 2.5	mAdc	
Gate-Body Leakage Current, Forward (V _{GSF} = 20 Vdc, V _{DS} = 0)	I _{GSSF}	—	500	nAdc	
Gate-Body Leakage Current, Reverse (V _{GSR} = 20 Vdc, V _{DS} = 0)	I _{GSSR}	—	500	nAdc	
ON CHARACTERISTICS*					
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 1 mA) T _J = 100°C	V _{GS(th)}	2 1.5	4.5 4	Vdc	
Static Drain-Source On-Resistance (V _{GS} = 10 Vdc, I _D = 6 Adc)	r _{DS(on)}	—	1.6	Ohm	
Drain-Source On-Voltage (V _{GS} = 10 V) (I _D = 6 Adc) (I _D = 4 Adc, T _J = 100°C)	V _{DS(on)}	—	9.6 13.6	Vdc	
Forward Transconductance (V _{DS} = 15 V, I _D = 4 A)	g _{FS}	2	10	mhos	
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V _{DS} = 25 V, V _{GS} = 0, f = 1 MHz) See Figure 11	C _{iss}	750	1500	pF
Output Capacitance		C _{oss}	75	400	
Reverse Transfer Capacitance		C _{rss}	25	150	
SWITCHING CHARACTERISTICS* (T_J = 100°C)					
Turn-On Delay Time	(V _{DD} = 125 V, I _D = 3 A R _{gen} = 50 ohms) See Figures 9, 13 and 14	t _{d(on)}	—	80	ns
Rise Time		t _r	—	150	
Turn-Off Delay Time		t _{d(off)}	—	200	
Fall Time		t _f	—	100	
Total Gate Charge	(V _{DS} = 0.8 Rated V _{DSS} , I _D = Rated I _D , V _{GS} = 10 V) See Figure 12	Q _g	55 (Typ)	65	nC
Gate-Source Charge		Q _{gs}	25 (Typ)	—	
Gate-Drain Charge		Q _{gd}	30 (Typ)	—	
SOURCE DRAIN DIODE CHARACTERISTICS*					
Forward On-Voltage	(I _S = 6 A, V _{GS} = 0)	V _{SD}	0.7	1.4	Vdc
Forward Turn-On Time		t _{on}	Limited by stray inductance		
Reverse Recovery Time		t _{rr}	—	1000	ns
INTERNAL PACKAGE INDUCTANCE					
Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)	L _d	5 (Typ)	—	nH	
Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad)	L _s	12.5 (Typ)	—		

*Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

查询"2N6826"供应商 TYPICAL ELECTRICAL CHARACTERISTICS

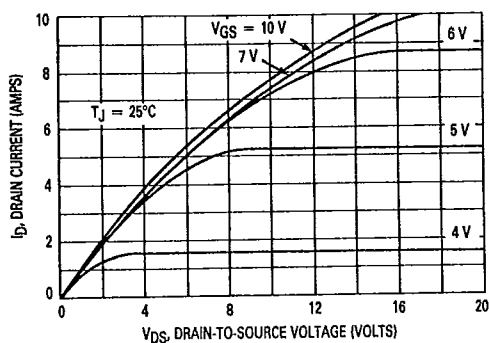


Figure 1. On-Region Characteristics

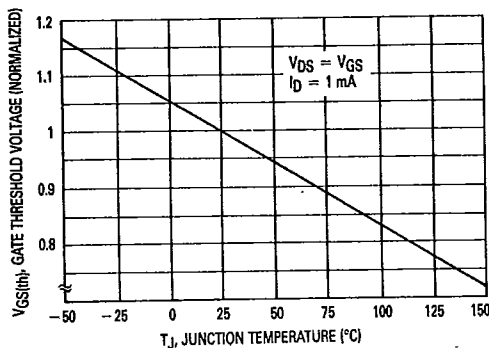


Figure 2. Gate-Threshold Voltage Variation With Temperature

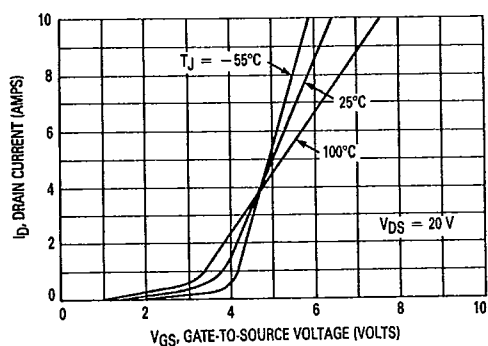


Figure 3. Transfer Characteristics

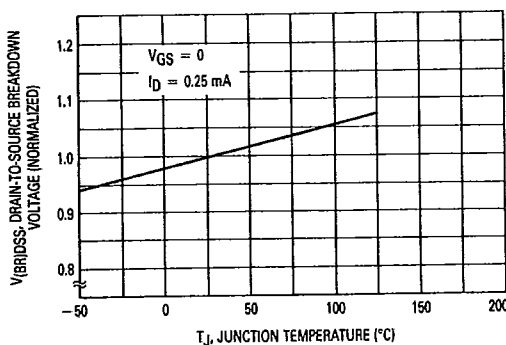


Figure 4. Breakdown Voltage Variation With Temperature

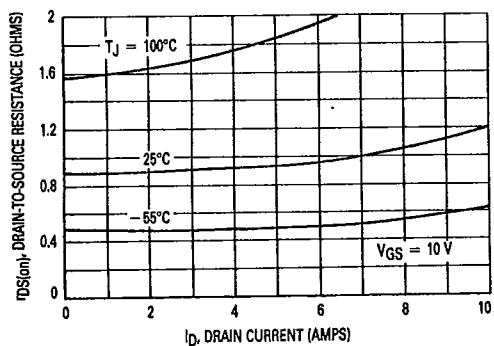


Figure 5. On-Resistance versus Drain Current

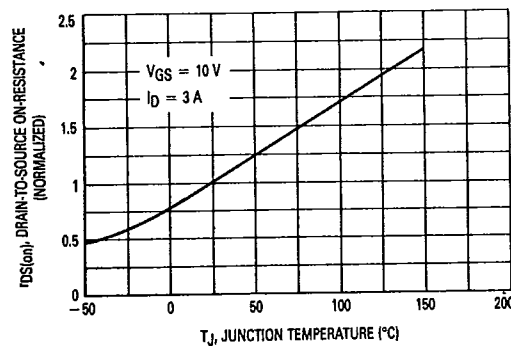


Figure 6. On-Resistance Variation With Temperature

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SAFE OPERATING AREA INFORMATION

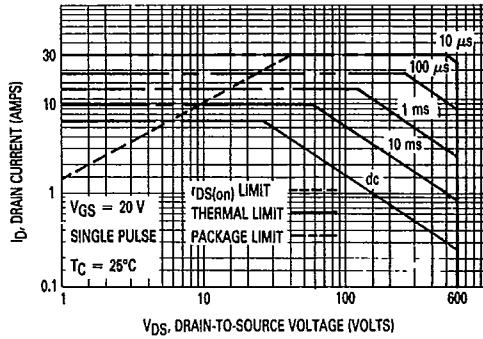


Figure 7. Maximum Rated Forward Biased Safe Operating Area

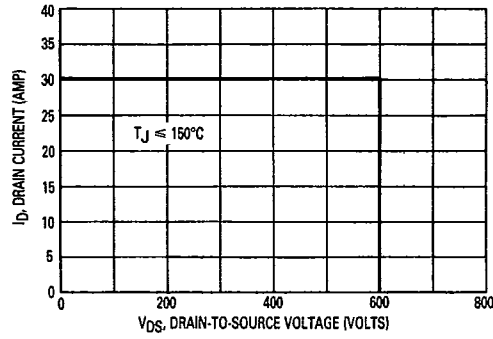


Figure 8. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V(BR)_{DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_J(max) - T_C}{R_{\theta JC}}$$

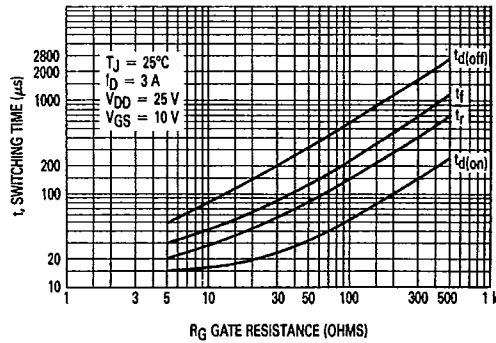


Figure 9. Resistive Switching Time Variation versus Gate Resistance

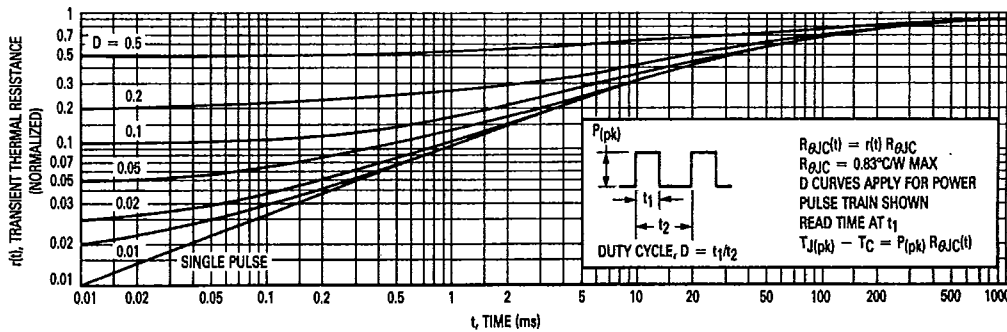


Figure 10. Thermal Response

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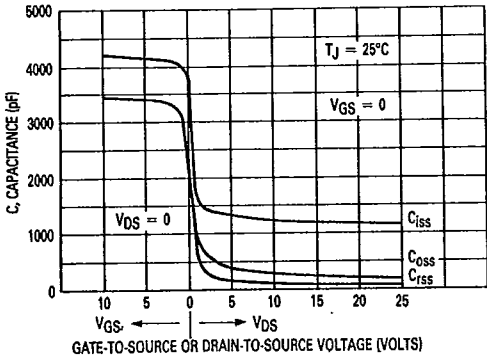


Figure 11. Capacitance Variation

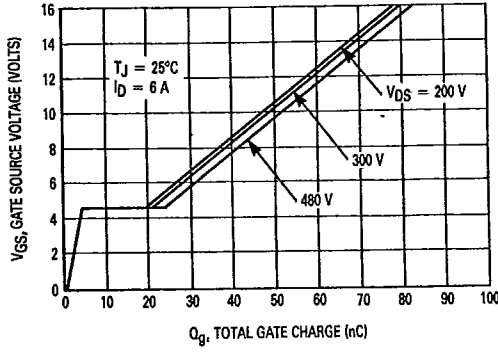


Figure 12. Gate Charge versus Gate-to-Source Voltage



RESISTIVE SWITCHING

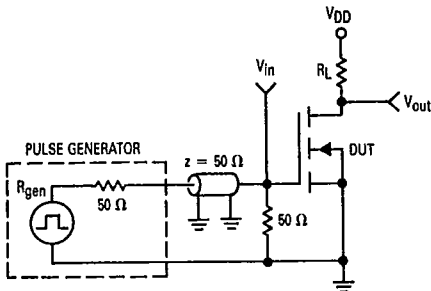


Figure 13. Switching Test Circuit

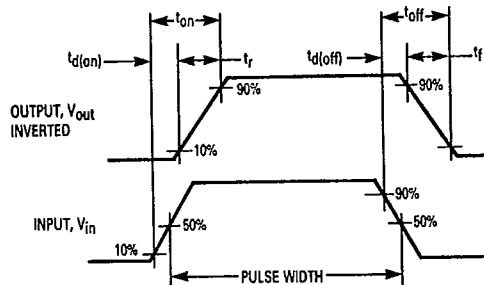


Figure 14. Switching Waveforms

OUTLINE DIMENSIONS

STYLE 3:
PIN 1. GATE
2. SOURCE
CASE DRAIN

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

CASE 1-06
TO-204AA

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	—	39.37	—	1.550
B	—	21.08	—	0.830
C	6.35	8.25	0.250	0.325
D	0.97	1.09	0.038	0.043
E	1.40	1.77	0.055	0.070
F	30.15 BSC	—	1.187 BSC	—
G	10.92 BSC	—	0.430 BSC	—
H	5.46 BSC	—	0.215 BSC	—
J	16.89 BSC	—	0.665 BSC	—
K	11.18	12.19	0.440	0.480
Q	3.84	4.19	0.151	0.165
R	—	26.67	—	1.050
U	4.83	5.33	0.190	0.210
V	3.84	4.19	0.151	0.165